







CD54HC688, CD74HC688, CD54HCT688, CD74HCT688 SCHS196E – SEPTEMBER 1997 – REVISED OCTOBER 2022

CDx4HC688, CDx4HCT688 High-Speed CMOS Logic 8-Bit Magnitude Comparator

1 Features

- Cascadable
- · Fanout (over temperature range)
 - Standard outputs: 10 LSTTL Loads
 - Bus driver outputs: 15 LSTTL Loads
- Wide operating temperature range: –55°C to 125°C
- · Balanced propagation delay and transition times
- Significant power reduction compared to LSTTL Logic ICs
- HC types
 - 2 V to 6 V operation
 - High noise immunity: N_{IL} = 30%, N_{IH} = 30% of V_{CC} at V_{CC} = 5 V
- HCT types
 - 4.5 V to 5.5 V operation
 - Direct LSTTL input logic compatibility, $V_{IL} = 0.8 \text{ V (max)}, V_{IH} = 2 \text{ V (min)}$
 - CMOS input compatibility, I_I ≤ 1 μA at V_{OL},V_{OH}

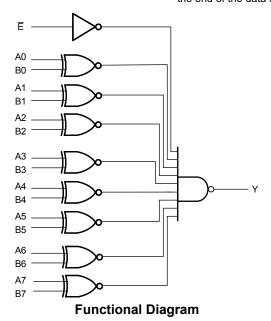
2 Description

The 'HC688 and 'HCT688 are 8-bit magnitude comparators designed for use in computer and logic applications that require the comparison of two 8-bit binary words. When the compared words are equal the output (Y) is low and can be used as the enabling input for the next device in a cascaded application.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE (NOM)
CD74HC688M	SOIC (20)	12.80 mm × 7.50 mm
CD74HCT688M	SOIC (20)	12.80 mm × 7.50 mm
CD74HC688E	PDIP (20)	25.40 mm × 6.35 mm
CD74HCT688E	PDIP (20)	25.40 mm × 6.35 mm
CD74HC688NSR	SO (20)	15.00 mm × 5.30 mm
CD74HC688PWR	TSSOP (20)	6.50 mm × 4.40 mm
CD54HC688F3A	CDIP (20)	26.92 mm × 6.92 mm
CD54HCT688F3A	CDIP (20)	26.92 mm × 6.92 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.





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3 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

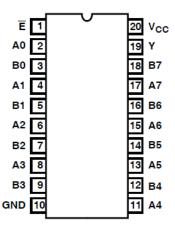
Changes from Revision D (February 2022) to Revision E (October 2022) Increased R0JA for packages: DW (58 to 109.1); N (69 to 84.6); NS (60 to 113.4); PW (83 to 131.8)......4

Changes from Revision C (August 2003) to Revision D (February 2022)

Updated the numbering, formatting, tables, figures, and cross-references throughout the document to reflect modern data sheet standards......1



4 Pin Configuration and Functions



J, N, DW, NS, or PW package 20-Pin CDIP, PDIP, SOIC, SO, TSSOP Top View



5 Specifications

5.1 Absolute Maximum Ratings⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage		-0.5	7	V
I _{IK}	Input diode current	For $V_1 < -0.5 \text{ V}$ or $V_1 > V_{CC} + 0.5 \text{ V}$		±20	mA
I _{OK}	Output diode current	For $V_O < -0.5 \text{ V}$ or $V_O > V_{CC} + 0.5 \text{ V}$		±20	mA
Io	Output source or sink current per output pin	For $V_O > -0.5 \text{ V}$ or $V_O < V_{CC} + 0.5 \text{ V}$		±25	mA
	Continuous current through V _{CC} or GND			±50	mA
TJ	Junction temperature			150	°C
T _{stg}	Storage temperature range	-65	150	°C	
	Lead temperature (Soldering 10s) (SOIC - lead	tips only)		300	°C

⁽¹⁾ Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress-only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

5.2 Recommended Operating Conditions

			MIN	MAX	UNIT	
V	Supply voltage range	HC types	2	6	V	
V _{CC}	Supply voltage range	HCT types	4.5	5.5	V	
V _I , V _O	Input or output voltage		0	V _{CC}	V	
		2 V		1000		
t _t	Input rise and fall time	4.5 V		500	ns	
		6 V		400		
T _A	Temperature range		– 55	125	°C	

5.3 Thermal Information

		DW (SOIC)	N (PDIP)	NS (SO)	PW (TSSOP)	
THERMAL METRIC		20 PINS	20 PINS	20 PINS	20 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽¹⁾	109.1	84.6	113.4	131.8	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	76	72.5	78.6	72.2	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	77.6	65.3	78.4	82.8	°C/W
ΨЈТ	Junction-to-top characterization parameter	51.5	55.3	47.1	21.5	°C/W
ΨЈВ	Junction-to-board characterization parameter	77.1	65.2	78.1	82.4	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	N/A	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.



5.4 Electrical Characteristics

	DADAMETED	TEST	V 00		25℃		–40℃ to 85℃		-55℃ to 125℃		LIMIT
	PARAMETER	CONDITIONS(2)	V _{CC} (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
HC TY	PES										
			2	1.5			1.5		1.5		
V_{IH}	High level input voltage		4.5	3.15			3.15		3.15		V
			6	4.2			4.2		4.2		
			2			0.5		0.5		0.5	
V _{IL}	Low level input voltage		4.5			1.35		1.35		1.35	V
			6			1.8		1.8		1.8	
		I _{OH} = -20 μA	2	1.9			1.9		1.9		
	High level output	I _{OH} = -20 μA	4.5	4.4			4.4		4.4		
V _{OH}	voltage	I _{OH} = -20 μA	6	5.9			5.9		5.9		V
	High level output	I _{OH} = -4 mA	4.5	3.98			3.84		3.7		
	voltage	I _{OH} = -5.2 mA	6	5.48			5.34		5.2		
		I _{OL} = 20 μA	2			0.1		0.1		0.1	
	Low level output	I _{OL} = 20 μA	4.5			0.1		0.1		0.1	
V _{OL}	voltage	I _{OL} = 20 μA	6			0.1		0.1		0.1	V
	Low level output	I _{OL} = 4 mA	4.5			0.26		0.33		0.4	
	voltage	I _{OL} = 5.2 mA	6			0.26		0.33		0.4	
I _I	Input leakage current	V _I = V _{CC} or GND	6			±0.1		±1		±1	μA
I _{CC}	Supply current	V _I = V _{CC} or GND	6			8		80		160	μA
нст т	YPES			,							
V _{IH}	High level input voltage		4.5 to	2			2		2		V
V IH	Tilgit level lilput voltage		5.5								v
V _{IL}	Low level input voltage		4.5 to 5.5			0.8		0.8		8.0	V
V	High level output voltage	I _{OH} = -20 μA	4.5	4.4			4.4		4.4		V
V _{OH}	High level output voltage	I _{OH} = –4 mA	4.5	3.98			3.84		3.7		V
.,	Low level output voltage	I _{OL} = 20 μA	4.5			0.1		0.1		0.1	.,
V _{OL}	Low level output voltage	I _{OL} = 4 mA	4.5			0.26		0.33		0.4	V
I _I	Input leakage current	V _I = V _{CC} or GND	5.5			±0.1		±1		±1	μA
I _{CC}	Supply current	V _I = V _{CC} or GND	5.5			8		80		160	μA
ΔI_{CC}	Additional supply	Enable inputs held at V _{CC} –2.1	4.5 to 5.5		100	252		315		343	μΑ
(1)	current per input pin	Data inputs held at V _{CC} –2.1	4.5 to 5.5		100	126		157.5		171.5	μΑ

⁽¹⁾ For dual-supply systems theoretical worst case (V_I = 2.4 V, V_{CC} = 5.5 V) specification is 1.8 mA. (2) V_I = V_{IH} or V_{IL} .



5.5 Switching Characteristics

 C_L = 50pF. Input t_r , t_f = 6 ns

	DADAMETED	V 00		25℃		–40℃ to 85℃	-55℃ to 125℃	UNIT
	PARAMETER	V _{CC} (V)	MIN	TYP	MAX	MIN MAX	MIN MAX	UNII
HC TYPE	S							
	B	2			170	210	255	
t _{PLH} , t _{PHL}	Propagation delay (Figure 6-1) An to output	4.5		14 ⁽³⁾	34	42	51	ns
	An to output	6			29	36	43	
		2			170	210	255	
t _{PLH} , t _{PHL}	Bn to output	4.5		14 ⁽³⁾	34	42	51	ns
		6			29	36	43	
		2			120	150	180	
t _{PLH} , t _{PHL}	Ē to output	4.5		9 ⁽³⁾	24	30	36	ns
		6			20	26	30	
	Output transition time (Figure 6-1)	2			75	95	110	
t _{TLH} , t _{THL}		4.5			15	19	22	ns
		6			13	16	19	
C _{IN}	Input capacitance				10	10	10	pF
C _{PD}	Power dissipation capacitance ⁽¹⁾ (2)			22(4)				pF
HCTTYPE	ES .							
t _{PLH} , t _{PHL}	Propagation delay (Figure 6-1) An to output	4.5		14 ⁽³⁾	34	42	51	ns
t _{PLH} , t _{PHL}	Bn to output	4.5		14 ⁽³⁾	34	42	51	ns
t _{PLH} , t _{PHL}	E to output	4.5		9 ⁽³⁾	24	30	36	ns
t _{TLH} , t _{THL}	Output transition time (Figure 6-1)	4.5			15	19	22	ns
C _{IN}	Input capacitance				10	10	10	pF
C _{PD}	Power dissipation capacitance ^{(1) (2)}	5		22 ⁽⁴⁾				pF

⁽¹⁾ C_{PD} is used to determine the dynamic power consumption, per gate. (2) $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$ where f_i = input frequency, C_L = output load capacitance, V_{CC} = supply voltage. (3) C_L = 15 pF and V_{CC} = 5 V. (4) C_L = 15 pF.



6 Parameter Measurement Information

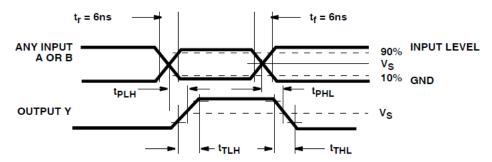


Figure 6-1. Propagation Delay and Transition Times

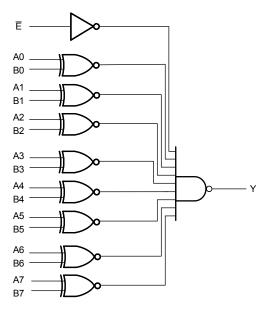


7 Detailed Description

7.1 Overview

The 'HC688 and 'HCT688 are 8-bit magnitude comparators designed for use in computer and logic applications that require the comparison of two 8-bit binary words. When the compared words are equal the output (Y) is low and can be used as the enabling input for the next device in a cascaded application.

7.2 Functional Block Diagram



7.3 Device Functional Modes

Table 7-1. Truth Table⁽¹⁾

INP	OUPUTS	
A, B	Ē	Υ
A = B	L	L
A ≠ B	L	Н
X	Н	Н

(1) H = high voltage level, L = low voltage level, X = don't care.



8 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1-µF capacitor is recommended for this device. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. The 0.1-µF and 1-µF capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

9 Layout

9.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices, inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V_{CC} , whichever makes more sense for the logic function or is more convenient.



10 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

10.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

10.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

10.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-8685701RA	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8685701RA CD54HCT688F3A	Samples
CD54HC688F3A	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8681801RA CD54HC688F3A	Samples
CD54HCT688F	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD54HCT688F	Samples
CD54HCT688F3A	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8685701RA CD54HCT688F3A	Samples
CD74HC688E	ACTIVE	PDIP	N	20	20	RoHS & Non-Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC688E	Samples
CD74HC688M96	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC688M	Samples
CD74HC688NSR	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC688M	Samples
CD74HC688PWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ688	Samples
CD74HCT688E	ACTIVE	PDIP	N	20	20	RoHS & Non-Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT688E	Samples
CD74HCT688EE4	ACTIVE	PDIP	N	20	20	RoHS & Non-Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT688E	Samples
CD74HCT688M96	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT688M	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽²⁾ **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

PACKAGE OPTION ADDENDUM

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- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CD54HC688, CD54HC7688, CD74HC688, CD74HC7688:

Catalog: CD74HC688, CD74HCT688

Military: CD54HC688, CD54HCT688

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications



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TAPE AND REEL INFORMATION



TAPE DIMENSIONS + K0 - P1 - B0 W Cavity - A0 -

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC688M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CD74HC688NSR	so	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
CD74HC688NSR	so	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
CD74HC688PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
CD74HC688PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
CD74HCT688M96	SOIC	DW	20	2000	330.0	24.4	10.9	13.3	2.7	12.0	24.0	Q1
CD74HCT688M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1



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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC688M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74HC688NSR	SO	NS	20	2000	367.0	367.0	45.0
CD74HC688NSR	SO	NS	20	2000	367.0	367.0	45.0
CD74HC688PWR	TSSOP	PW	20	2000	356.0	356.0	35.0
CD74HC688PWR	TSSOP	PW	20	2000	356.0	356.0	35.0
CD74HCT688M96	SOIC	DW	20	2000	356.0	356.0	41.0
CD74HCT688M96	SOIC	DW	20	2000	367.0	367.0	45.0

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD74HC688E	N	PDIP	20	20	506	13.97	11230	4.32
CD74HCT688E	N	PDIP	20	20	506	13.97	11230	4.32
CD74HCT688EE4	N	PDIP	20	20	506	13.97	11230	4.32

14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
 C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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